

5

PATTERN-BASED DEFECT DESCRIPTION METHOD

Related Applications

The present application claims benefit of the United States
10 provisional patent application number 60/205,925, filed May 22, 2000.

Field Of the Invention

The present invention relates generally to disc drives. More
15 particularly, the present invention relates to a method for describing defects found in the recording media.

Background of the Invention

20 During certification of disc drives, media defects are identified and their addresses are stored in a reserve part of the recording media in the form of a defect table. Upon power-on of the disc drive, the defect table is retrieved and stored in a buffer memory, thus enabling the drive electronics to skip over the defective sectors during disc drive operations.

25 As drive capacities continue to grow rapidly, the number of media defects also increase. Although more of the recording media can be set aside for storing the defect table, increasing the buffer memory for storing defect information is a very costly option. Currently, a scratch across N tracks in the radial direction of the disc will require N number of defect
30 table entries to represent the defects. With the average tracks per inch (tpi) projected to hit 100,000 tpi, a quarter-inch radial scratch will require 25,000 defect entries to represent it. This creates a very large memory requirement for storing only the defect table.

09851767-050901
T06050" 292T5860

5 The United States Patent 5,212,677 issued to Shimote et al. on May
18, 1993, describes an apparatus for conducting visual inspection of surface
defects. The apparatus groups neighboring defects into clusters and
determines the size of each clusters. Although a method of identifying and
storing information on cluster-like defects is taught, it does not provide a
10 compressed description of scratch-like defects, particularly irregularly
shaped defects or defects that run across a number of tracks.

Scratch-filling algorithms are often applied during drive
certification to pad existing defects to prevent the growth of these defects.
This involves marking good sectors neighboring the defective sectors as
15 defective sectors. As a result, the final defect table after drive certification is
usually bigger than the original defect table.

To cope with the growing number of defects in high-density disc
drives, there is a need for a more compact method of storing the defect
table.

20

Summary of the Invention

The present invention provides a method of describing defects that
requires less memory space than conventional methods. At the end of
25 certification process, defects captured are stored in a certification log which
is referred to as a first defect table in this discussion. A conversion process
is carried out to convert the certification log to a compressed defect table,
The compressed defect table is referred to as a second defect table. This
second defect table will be stored in the buffer and used by the firmware to
30 skip over defects during operation. The conversion starts with sorting the
entries of a first defect table according to the type of track layout, or zones.
They are then grouped into clusters. Each cluster is characterized by a set
of new parameters, including a starting sector, a scratch parameter, a span
parameter, and an angle parameter. The new parameters are stored in a

09851767-050901
T06050" 2975860

5 second table, replacing the corresponding entries in the first table. In this manner, a single entry in the second table replaces one or more entries in the first table. In particular, as defective sectors in different tracks may be represented by one single entry in the second table, the present method is more efficient in representing defects caused by scratches on the discs.

10 In a preferred embodiment, defect-padding techniques may be incorporated. The invention offers an additional advantage over the prior art in that even after defect padding, the number of defect entries may be kept constant or even further reduced.

15

Brief Description of the Drawings

FIG. 1 is a perspective view of a disc drive.

FIG. 2 is a diagrammatic representation of defective sectors in a zone
20 to which the present invention may be applied.

FIG. 3 shows one possible distribution of defective sectors.

FIG. 4 shows another possible arrangement of defective sectors in a zone.

FIG. 5 illustrates yet another possible distribution of defective
25 sectors.

FIG. 6 shows a possible distribution of defective sectors for the purpose of illustrating how the present invention may be applied to obtain further compression of the defect description.

30

Detailed Description

Preferred embodiments of the present invention will now be described with reference to the drawings. Referring first to FIG. 1, there is

09851767-050901
106050-29275860

5 shown a disc drive 10, such as one in which the present invention may be implemented.

The disc drive 10 includes at least one disc 12 with surfaces on which data can be stored. Data is generally stored in concentric tracks 14, a few of which are illustrated in FIG. 1. Each track is divided into sectors 18,
10 each being an addressable unit of data storage space.

To read or write data to the disc 12, a head 24 is first brought into position by an actuator 22. The actuator 22 may be motivated by a voice coil motor 20 that rotates the actuator arm 26 about a pivot 28 so that the head 24 supported at the end of the actuator arm 26 comes to rest over the
15 particular track. The disc 12 is usually annular and mounted on a spindle motor 30. During a read or write operation, the disc 12 is rotated by the spindle motor 30 so that the appropriate sectors are brought into proximity with the head 24.

To pack more data into a given track area, track widths are reduced.
20 As a result, a small scratch on the disc surface may render numerous sectors across a number of tracks unsuitable for data storage. Other irregularities on the disc surface may also result in defective sectors. Once a sector is identified to be defective, its address is stored in a defect table so that it will not be utilized for data storage. The defect table may be stored
25 on the disc, or when the disc drive is in operation, in a buffer memory.

A most preferred embodiment of the present invention involves providing a second defect table to replace entries in the first defect table. The first defect table stores the addresses of defective sectors in a conventional manner which typically requires at least one defect entry for
30 each contiguous group of defective sectors on the same track. For the purpose of illustration, Table 1 shows the defect entries in the first defect table corresponding to the defective sectors which are shown as single-hatched boxes 52 in FIG. 2.

0985167-050901

5

Table 1

	Cylinder	Head	Sector	Span
	1	2	1	1
	2	2	2	1
10	3	2	3	1
	4	2	4	1
	5	2	5	1
	6	2	6	1

15 The cylinder number 60 identifies the track. The head number indicates the disc surface concerned. In combination with the sector number 62, the location of a defective sector 52 can be identified. The span number in this example is "1" because only one sector is defective in each track.

20 To further maximize drive capacity, the tracks may be grouped into zones with data written at different rates for the various zones, using the known technique of zone-bit recording. To simplify the compression procedure, the sectors are analyzed zone by zone. To do this, the defect entries in the first defect table are sorted by their zones. For the purpose of
25 illustration, it is assumed that FIG. 2 shows all the sectors 18 in one zone 40, where the unshaded boxes 50 represent good sectors. All the defective sectors in the same zone are then grouped into one or more clusters. In this example, all the defective sectors are grouped into one cluster 42.

30 For each cluster, one of the defective sectors is chosen to be a reference sector 34. Preferably, the reference sector, or the starting sector, is the sector having the smallest cylinder number and the smallest sector number in that cylinder. Alternatively, the starting sector can be taken to be the sector with the largest address.

05951767.05951

5
10

15

20

20

25

Another example will be described with the aid of FIG. 3, which shows, among the good sectors 50, defective sectors 52 resulting from a scratch on the disc surface. A conventional method of defect representation may produce a first defect table as given below in Table 3.

5

Table 3

	Cylinder	Head	Sector	Span
	1	2	1	2
10	2	2	2	2
	3	2	3	2
	4	2	4	2
	5	2	5	2
	6	2	6	2

15

These defective sectors 52 are grouped together to form a cluster 42. Using the same rule as before, a starting sector is chosen 34. Alternatively, the starting sector may be chosen by some other rules. Here, the sector having cylinder number = 1 and sector number = 1 is chosen to be the starting sector.

20

According to the present invention, the cluster of defective sectors may be represented by a single set of parameters stored in a second defect table, as shown by Table 4. The span parameter is "2" to indicate the width of the scratch.

25

Table 4

Cylinder	Head	Sector	Scratch	Angle	Span
1	2	1	6	1	2

30

FIG. 4 illustrates another cluster 42 of defective sectors 52 which, according to the present invention, may be represented by a single defect entry as shown in Table 5.

5

Table 5

Cylinder	Head	Sector	Scratch	Angle	Span
1	2	6	6	-2	2

10

The angle parameter may be derived by various methods. In the foregoing examples, it is taken to be the tangent of the angle between a radial line 44 on the disc and an imaginary line 46 drawn from the starting sector to pass through the first defective sector in subsequent tracks.

15

FIG. 5 shows a situation where there are defective sectors 52 that are not adjacent to at least one other defective sector in the same zone 40. Both the double-hatched boxes 48 and the unshaded boxes 50 represent good sectors. The single-hatched boxes 52 represent defective sectors. A conventional defect table may be represented by Table 6.

20

Table 6

Cylinder	Head	Sector	Span
2	2	2	1
3	2	4	3
4	2	4	3
5	2	4	3

25

According to the present invention, two clusters 54, 56 may be defined: one consisting of only one defective sector and another consisting of the remaining nine defective sectors. The four defect entries may therefore be replaced by two entries in the second defect table, such as one shown in Table 7.

30

5

Table 7

	Cylinder	Head	Sector	Scratch	Angle	Span
	2	2	2	1	N/A	1
10	3	2	4	3	0	3

An alternative embodiment may incorporate defect-padding techniques so as to prevent the growth of a defect. Consider the example in FIG. 5. Incorporating defect padding, the entries in the second table are modified to include the adjacent sectors that are not currently defective. In this example, the good sectors represented by double-hatched boxes 48 are included in the cluster 58 for the purpose of defect padding. The defect entry using the pattern representation may then be as shown in Table 8.

20

Table 8

Cylinder	Head	Sector	Scratch	Angle	Span
2	2	2	5	0	6

25

Although the number of tagged sectors has increased, the memory space required to store the identity of the tagged sectors has not. Depending on the pattern chosen, the degree of compression may be increased. Consider the example in FIG. 6, again, the double-hatched boxes 48 and the unshaded boxes 50 represent good sectors while the single-hatched boxes 52 represent defective sectors. Instead of replacing the four defect entries in Table 9 with the two entries in Table 10, an alternative pattern can be applied such that only one defect entry is required. For example, some of the good sectors 48 adjacent the defective sectors 42 may

30

09851767-050901

- 5 be considered as part of the same cluster, after the manner of defect padding, to produce a single entry as shown in Table 11.

Table 9

10	Cylinder	Head	Sector	Span
	2	2	2	1
	3	2	2	1
	4	2	4	1
	5	2	4	1

15

Table 10

	Cylinder	Head	Sector	Scratch	Angle	Span
20	2	2	2	2	0	1
	4	2	4	2	0	1

Table 11

25	Cylinder	Head	Sector	Scratch	Angle	Span
	2	2	2	4	2	2

- 30 Therefore, the present invention may be applied to compress the description of defective sectors which do not lie on contiguous tracks or which are not adjacent to each other. This is particularly useful for compressing defect entries for scratches, and can be extended to other defects which may be roundish or irregularly shaped.

5 Alternatively, preferred embodiments of the invention may be described as follows:

10 In a disc drive 10 having at least one disc 12 having a plurality of addressable sectors arranged in a plurality of tracks 14 on a surface of the disc such that data is capable of being written to and read from the sectors, there is provided a method of storing information on defective sectors 52. The method involves defining a cluster 42 comprising at least one defective sector 52, selecting one sector from the cluster to be a reference sector 34, and defining parameters with reference to the reference sector 34. The parameters chosen describe the shape and size of the cluster. The method
15 further includes storing the parameters with an address of the reference sector 34. Where the sectors are categorised into zones 40 such that data is written to and read from different zones at different rates, the method is applied by first sorting defective sectors 52 by zone before performing the aforementioned steps separately for each zone 40.

20 The cluster 58 may be defined such that it includes at least one non-defective sector 48. According to one embodiment, the sector with the smallest address is selected to be the reference sector 34. In another embodiment, the sector with the largest address is selected to be the reference sector 34.

25 Preferably, a scratch parameter characterizing the number of tracks 14 covered by the cluster 42 is one of the parameters defined. Another parameter that is defined includes a span parameter that characterizes the number of sectors 18 covered by the cluster 42 along each track 14. The method further includes defining an angle parameter characterizing the
30 angular deviation of a side 46 of the cluster from a reference line 44 intersecting the reference sector 34. The reference line may be defined by a radial line 44.

 The foregoing disclosure is intended to be illustrative only. It will be appreciated by those skilled in the art that variations may be made without

09851767-050904
" 29275860

- 5 departing from the scope and spirit of the invention. For example, different rules on cluster formation may be implemented to incorporate various defect-padding techniques, other than those described in the foregoing.

09851767 .050901